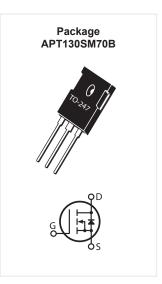


Silicon Carbide N-Channel Power MOSFET

DESCRIPTION

Silicon carbide (SiC) power MOSFET product line from Microsemi increase your performance over silicon MOSFET and silicon IGBT solutions while lowering your total cost of ownership for high-voltage applications.



FEATURES / TYPICAL APPLICATIONS

SiC MOSFET Features:

- Low on-resistance virtually independent on the ambient temperature
- · Low capacitances and low gate charge
- Fast switching speed due to low internal gate resistance (ESR)
- Stable operation at high junction temperature, Tj(max) = +175C
- · Fast and reliable body diode
- Superior avalanche ruggedness

SiC MOSFET Benefits:

- High efficiency to enable lighter/compact system
- · Simple to drive and easy to parallel
- Improved thermal capabilities and lower switching losses
- Eliminates the need of external Free Wheeling Diode
- · Lower system cost of ownership

Applications:

- PV inverter, converter and industrial motor drives
- Smart grid transmission & distribution
- Induction heating, and welding
- H/EV powertrain and EV charger
- · Power supply and distribution

MAXIMUM RATINGS

Symbol	Parameter	Ratings	Unit
V _{DSS}	Drain Source Voltage	700	V
I	Continuous Drain Current @ T _c = 25°C	110	
ι _D	Continuous Drain Current @ T _c = 100°C	78	A
I _{DM}	Pulsed Drain Current ^①	262	
V _{GS}	Gate-Source Voltage	-10 to +25	V
D	Total Power Dissipation @ $T_c = 25^{\circ}C$	556	W
P _D	Linear Derating Factor	3.7	W/°C

THERMAL AND MECHANICAL CHARACTERISTICS

Symbol	Characteristic	Min	Тур	Max	Unit
R _{ejc}	Junction to Case Thermal Resistance		0.22	0.27	°C/W
T	Operating Junction Temperature	-55		175	
T _{stg}	Storage Junction Temperature Range	-55		150	°C
T	Soldering Temperature for 10 Seconds (1.6mm from case)			260	
Tanana	Mounting Torque (TO-247 Package), 6-32 or M3 screw			10	in∙lbf
Torque				1.1	N∙m

STATIC CHARACTERISTICS

Symbol	Parameter	Test Co	Min	Тур	Max	Unit	
V _{(BR)DSS}	Drain-Source Breakdown Voltage	V _{GS} = 0V,	700			V	
R _{DS(on)}	Drain-Source On Resistance②	V _{GS} = 20\		35	45	mΩ	
V _{GS(th)}	Gate-Source Threshold Voltage	$V_{GS} = V_{DS}, I_{D} = 1mA$		1.7	2.4		V
$\Delta V_{GS(th)} / \Delta T_J$	Threshold Voltage Temperature Coefficient				-5.10		mV/°C
1	Zero Gate Voltage Drain Current	V _{DS} = 700V V _{GS} = 0V	T _J = 25°C			100	
DSS			T _J = 150°C			250	μA
I _{GSS}	Gate-Source Leakage Current	V _{GS} = +20V / -10V				±100	nA
ESR	Equivalent Series Resistance	f = 1MHz, 25mV, Drain Short			0.46		Ω

T_J = 25°C unless otherwise specified

DYNAMIC CHARACTERISTICS

Symbol	Parameter	Test Conditions	Min	Тур	Max	Unit
C _{iss}	Input Capacitance		1	3950		
C _{rss}	Reverse Transfer Capacitance	$V_{GS} = 0V, V_{DD} = 700V$		50		pF
C _{oss}	Output Capacitance	f = 1MHz		465		1
Q _g	Total Gate Charge	V _{GS} = 0/20V	1	220		nC
Q _{gs}	Gate-Source Charge	V _{DD} = 466V		42		
Q _{gd}	Gate-Drain Charge	I _D = 60A		61		
t _{d(on)}	Turn-On Delay Time	V _{DD} = 466V		17		- ns - µJ
t,	Current Rise Time	V _{GS} = 0/20V		15		
t _{d(off)}	Turn-Off Delay Time	$I_{\rm D} = 60A$		36		
t _r	Current Fall Time	$R_{g} = 3.0\Omega^{\textcircled{3}}$		19		
E _{on2}	Turn-On Switching Energy ^④	L = 115 μH Τ_ = 25°C		1060		
E _{off}	Turn-Off Switching Energy	Freewheeling Diode = APT20SCE65B		305		
t _{d(on)}	Turn-On Delay Time	V _{DD} = 466V	V _{DD} = 466V 16	16	İ	İ
t,	Current Rise Time	V _{GS} = 0/20V		15		- ns
t _{d(off)}	Turn-Off Delay Time	$I_{\rm D} = 60 \text{A}$		39		
t _f	Current Fall Time	$R_{g} = 3.0 \Omega^{3}$		21		
E _{on2}	Turn-On Switching Energy	L = 115 μH Τ _c = 150°C		965		
E _{off}	Turn-Off Switching Energy	Freewheeling Diode = APT20SCE65B		345		μJ

Source-Drain Diode Characteristics

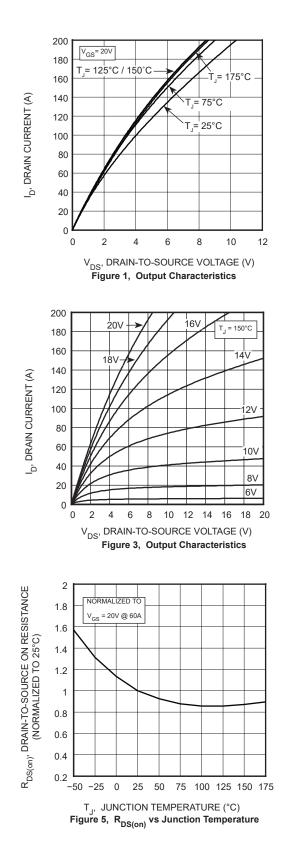
Symbol	Parameter	Test Conditions	Min	Тур	Мах	Unit
V _{SD}	Diode Forward Voltage	I _{SD} = 60A, V _{GS} = 0V		3.85		V
t _{rr}	Reverse Recovery Time	I _{SD} = 60A, V _{DD} = 466V dI/dt = -1000A/μs		68		ns
Q _{rr}	Reverse Recovery Charge			570		nC
I _{rrm}	Reverse Recovery Current			15.3		А

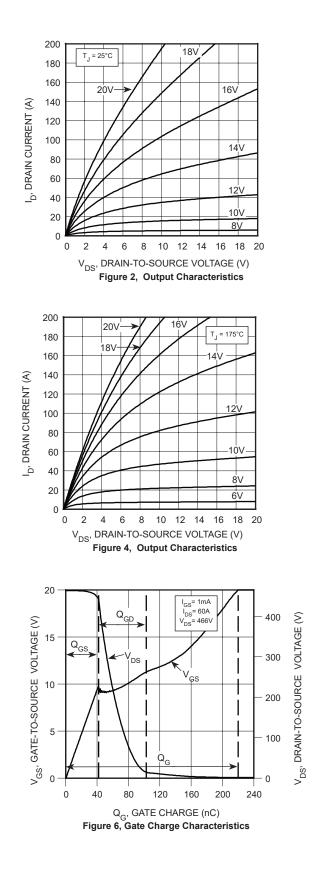
 $T_J = 25^{\circ}C$ unless otherwise specified

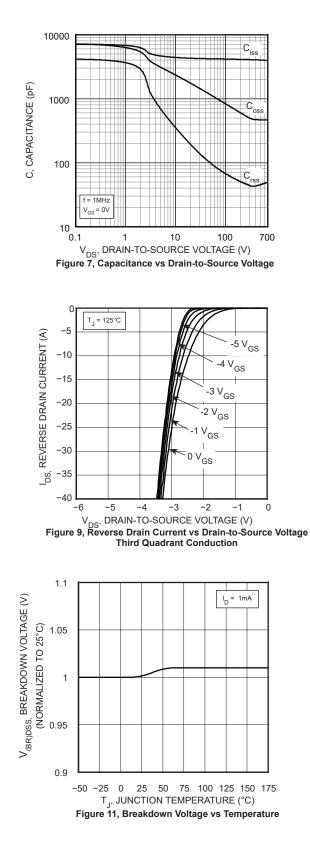
(1) Repetitive Rating: Pulse width and case temperature limited by maximum junction temperature

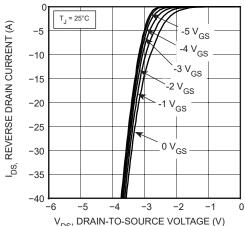
(d) E_{on2} includes energy of APT20SCE65B free wheeling diode.

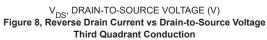


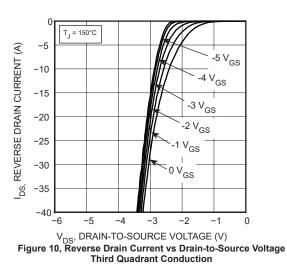


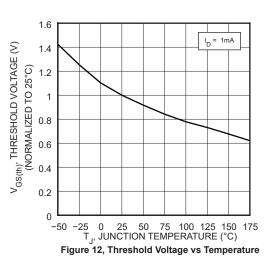






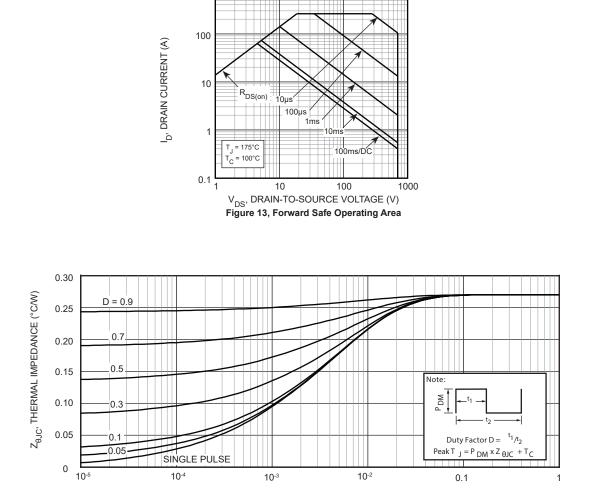






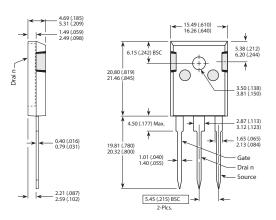






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TO-247 (B) Package Outline



Dimensions in Millimeters (Inches)

RECTANGULAR PULSE DURATION (SECONDS) Figure 14, Maximum Effective Transient Thermal Impedance, Junction-To-Case vs Pulse Duration

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Microsemi Corporate Headquarters One Enterprise, Aliso Viejo, CA 92656 USA Within the USA: +1 (800) 713-4113 Outside the USA: +1 (949) 380-6100 Sales: +1 (949) 380-6136 Fax: +1 (949) 215-4996 email: sales.support@microsemi.com www.microsemi.com

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